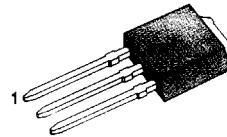
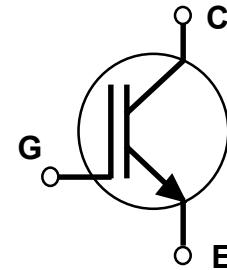


FEATURES

- * High Speed Switching
- * Low Saturation Voltage
: $V_{CE}(\text{sat}) = 2.1 \text{ V}$ (@ $I_C=3\text{A}$)
- * High Input Impedance

I - PAK**APPLICATIONS**

- * AC & DC Motor controls
- * General Purpose Inverters
- * Robotics , Servo Controls
- * Power Supply
- * Lamp Ballast

**ABSOLUTE MAXIMUM RATINGS**

Symbol	Characteristics	Rating	Units
V_{CES}	Collector-Emitter Voltage	600	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_c = 25^\circ\text{C}$	6	A
	Collector Current @ $T_c = 100^\circ\text{C}$	3	A
$I_{CM(1)}$	Pulsed Collector Current	25	A
P_c	Maximum Power Dissipation @ $T_c = 25^\circ\text{C}$	30	W
	Maximum Power Dissipation @ $T_c = 100^\circ\text{C}$	12	W
T_j	Operating Junction Temperature	-55 ~ 150	$^\circ\text{C}$
T_{stg}	Storage Temperature Range	-55 ~ 150	$^\circ\text{C}$
T_L	Maximum Lead Temp. For Soldering Purposes, $\frac{1}{8}''$ from case for 5 seconds	300	$^\circ\text{C}$

Notes:(1) Repetitive rating : Pulse width limited by max. junction temperature

ELECTRICAL CHARACTERISTICS

($T_c=25^\circ\text{C}$, Unless Otherwise Specified)

Symbol	Characteristics	Test Conditions	Min	Typ	Max	Units
BV_{CES}	C - E Breakdown Voltage	$V_{\text{GE}} = 0\text{V}$, $I_C = 250\mu\text{A}$	600	-	-	V
$\Delta V_{\text{CES}/\Delta T_J}$	Temperature Coeff. of Breakdown Voltage	$V_{\text{GE}} = 0\text{V}$, $I_C = 1\text{mA}$	-	0.6	-	V/ $^\circ\text{C}$
$V_{\text{GE}(\text{th})}$	G - E threshold voltage	$I_C = 3\text{mA}$, $V_{\text{CE}} = V_{\text{GE}}$	4.0	5.5	7.5	V
I_{CES}	Collector cutoff Current	$V_{\text{CE}} = V_{\text{CES}}$, $V_{\text{GE}} = 0\text{V}$	-	-	250	μA
I_{GES}	G - E leakage Current	$V_{\text{GE}} = V_{\text{GES}}$, $V_{\text{CE}} = 0\text{V}$	-	-	100	nA
$V_{\text{CE}}(\text{sat})$	Collector to Emitter saturation voltage	$I_C = 3\text{A}$, $V_{\text{GE}} = 15\text{V}$	-	2.1	2.6	V
		$I_C = 6\text{A}$, $V_{\text{GE}} = 15\text{V}$	-	2.6	-	V
Cies	Input capacitance	$V_{\text{GE}} = 0\text{V}$, $f = 1\text{MHz}$ $V_{\text{CE}} = 30\text{V}$	-	220	-	pF
Coes	Output capacitance		-	22	-	pF
Cres	Reverse transfer capacitance		-	7	-	pF
td(on)	Turn on delay time	$V_{\text{CC}} = 300\text{V}$, $I_C = 3\text{A}$ $V_{\text{GE}} = 15\text{V}$ $R_G = 80 \Omega$ Inductive Load	-	15	-	ns
tr	Turn on rise time		-	22	-	ns
td(off)	Turn off delay time		-	40	70	ns
tf	Turn off fall time		-	80	160	ns
Eon	Turn on Switching Loss		-	75	-	uJ
Eoff	Turn off Switching Loss		-	30	-	uJ
Ets	Total Switching Loss		-	100	125	uJ
Qg	Total Gate Charge	$V_{\text{CC}} = 300\text{V}$ $V_{\text{GE}} = 15\text{V}$ $I_C = 3\text{A}$	-	15	22	nC
Qge	Gate-Emitter Charge		-	5	8	nC
Qgc	Gate-Collector Charge		-	4	6	nC
Le	Internal Emitter Inductance	Measured 5mm from PKG	-	7.5	-	nH

THERMAL RESISTANCE

Symbol	Characteristics	Min	Typ	Max	Units
R_θ JC	Junction-to-Case	-	-	4.0	°C/W
R_θ JA	Junction-to-Case	-	-	110	°C/W
R_θ CS	Case-to-Sink	-	1.7	-	°C/W

SGU6N60UF

N-CHANNEL IGBT

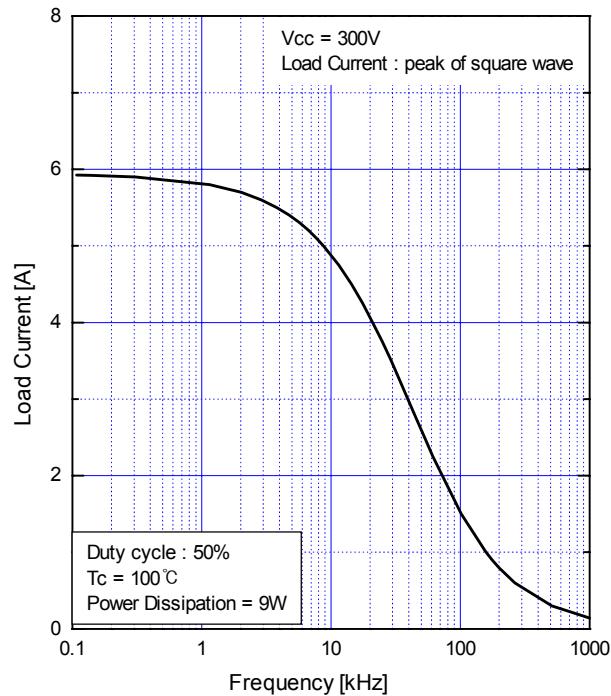


Fig.1 Typical Load Current vs. Frequency

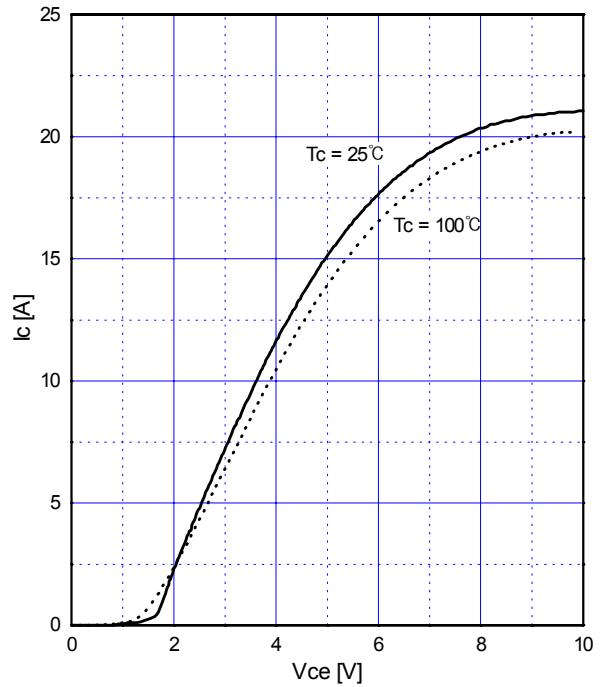


Fig.2 Typical Output Characteristics

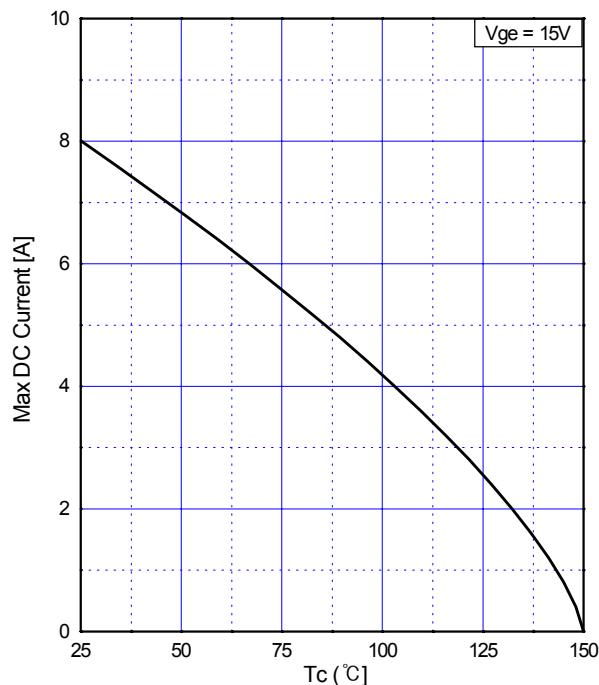


Fig.3 Maximum Collector Current vs. Case Temperature

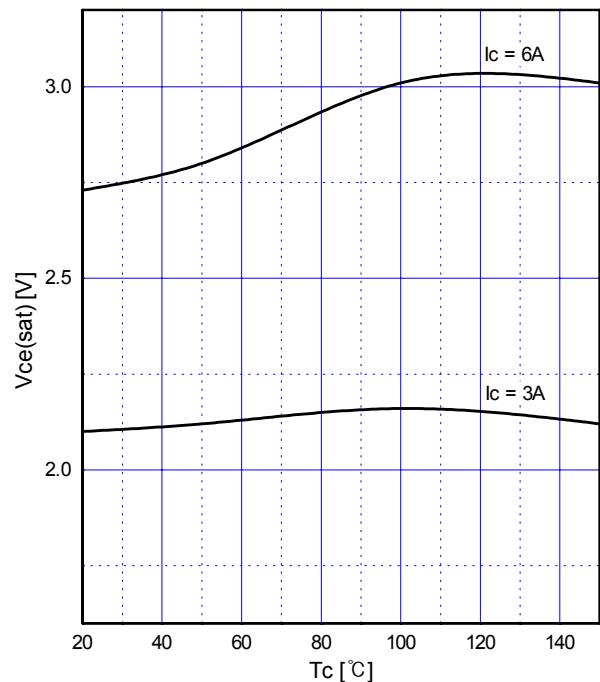


Fig.4 Collector to Emitter Voltage vs. Case Temperature

SGU6N60UF

N-CHANNEL IGBT

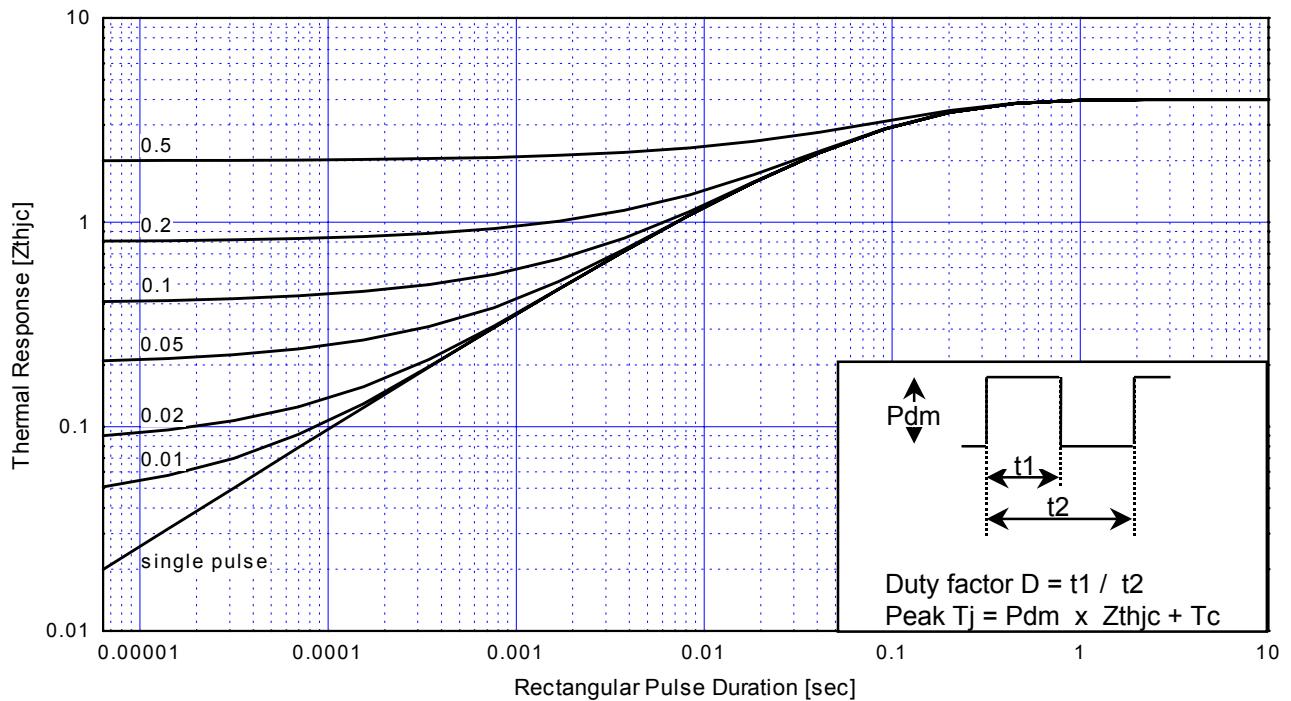


Fig.5 Maximum Effective Transient Thermal Impedance, Junction to Case

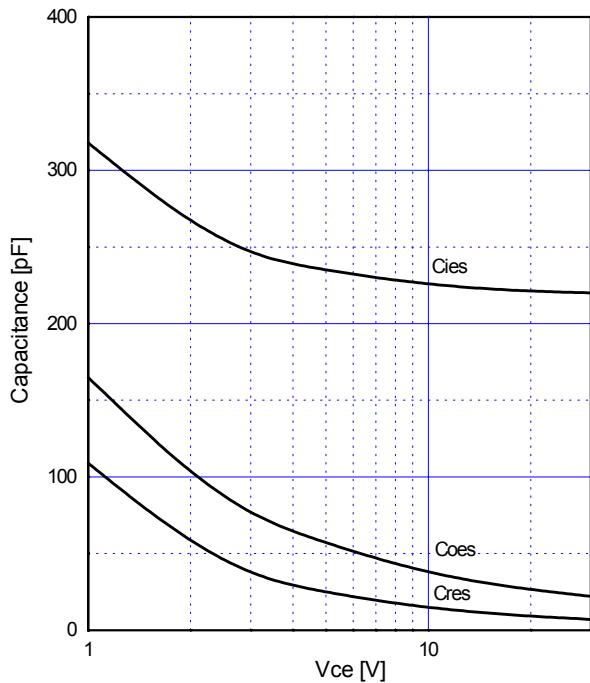


Fig.6 Typical Capacitance vs.
Collector to Emitter Voltage

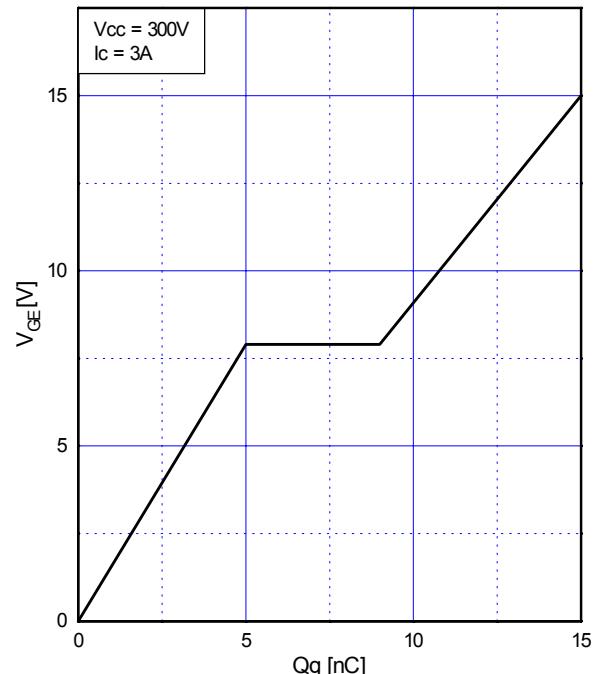


Fig.7 Typical Gate Charge vs.
Gate to Emitter Voltage

SGU6N60UF

N-CHANNEL IGBT

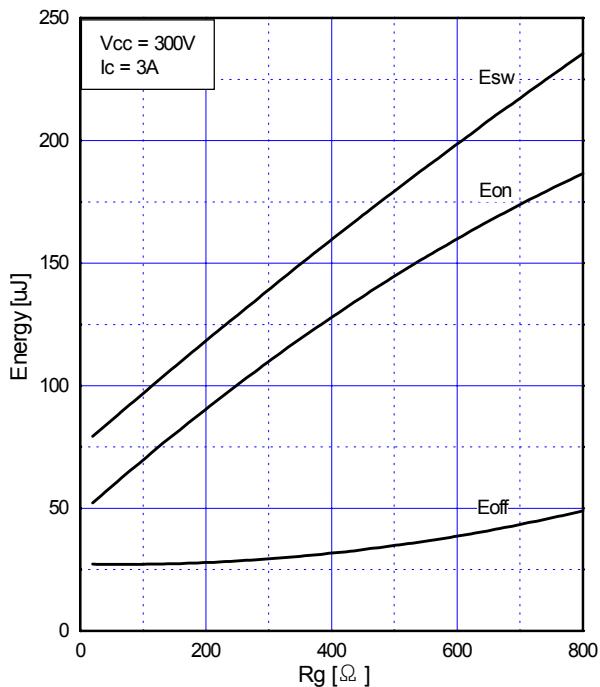


Fig.8 Typical Switching Loss vs.
Gate Resistance

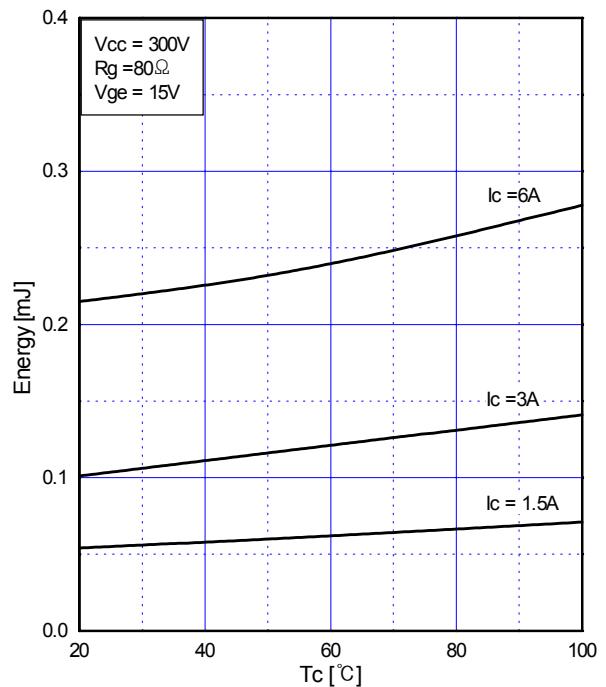


Fig.9 Typical Switching Loss vs.
Case Temperature

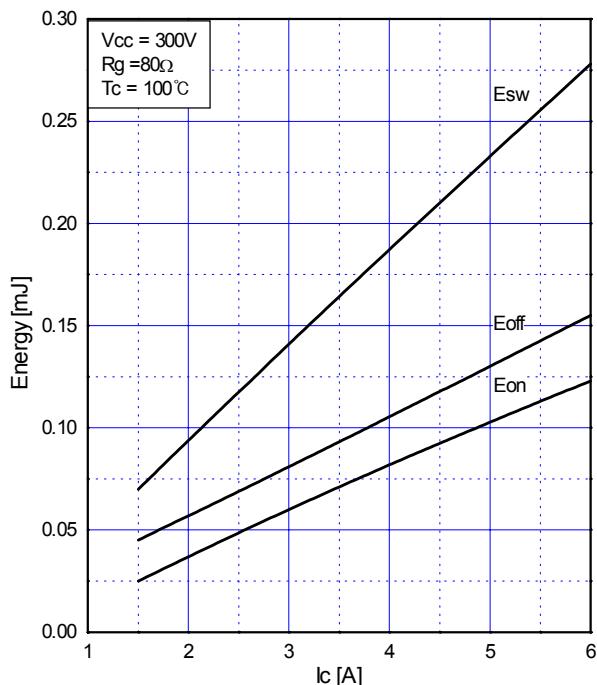


Fig.10 Typical Switching loss vs.
Collector to Emitter Current

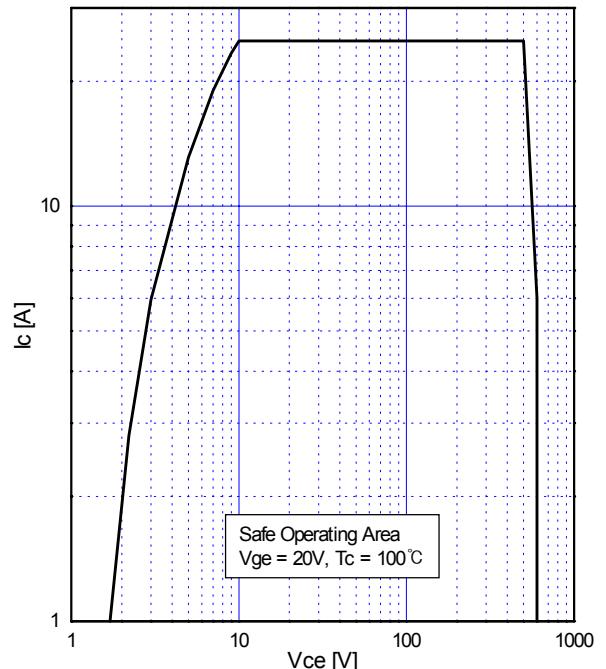


Fig.11 Turn-off SOA